

<b>Search Notes</b> 				<b>Application/Control No.</b> 10/700,670 <b>Examiner</b> Paul Dinh	<b>Applicant(s)/Patent under Reexamination</b> YOSHIDA ET AL.	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
716	4-6, 11, 18	9/13/2005	PD	EAST, IEEE	9/13/2005	PD
703	15, 19	9/13/2005	PD			
<b>INTERFERENCE SEARCHED</b>				<b> </b>		
Class	Subclass	Date	Examiner			
search	above	9/13/2005	PD			
<b> </b>				<b> </b>		